

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/657,700	NIEMENMAA, JARKO	
		Examiner	Art Unit	Page 1 of 1
		Charles Shedrick	2687	

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Examiner Charles Shedrick		Art Unit 2687	Page 1 of 1	

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